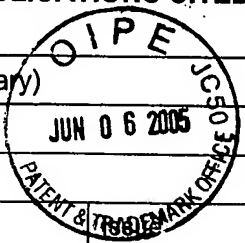


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LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT (Use several sheets if necessary)				Applicant Shih-Fu Lee		Confirmation No.:		
Examiner				Filing Date		Group		
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.								

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	B5						<input type="checkbox"/>	<input type="checkbox"/>
	B6						<input type="checkbox"/>	<input type="checkbox"/>

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